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A single-input, single-output electromagnetically-transduced microresonator array

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Abstract
Resonant microsystems have found broad applicability in environmental and inertial sensing, signal filtering and timing applications. Despite this breadth in utility, a common constraint on these devices is throughput, or the total amount of information that they can process. In recent years, elastically-coupled arrays of microresonators have been used to increase the throughput in sensing contexts, but these arrays are often more complicated to design than their isolated counterparts, due to the potential for collective behaviors (such as vibration localization) to arise. An alternative solution to the throughput constraint is to use arrays of electromagnetically-transduced microresonators. These arrays can be designed such that the mechanical resonances are spaced far apart and the mechanical coupling between the microresonators is insignificant. Thus, when the entire array is actuated and sensed, a resonance in the electrical response can be directly correlated to a specific microresonator vibrating, as collective behaviors have been avoided. This work details the design, analysis and experimental characterization of an electromagnetically-transduced microresonator array in both low- and atmospheric-pressure environments, and demonstrates that the system could be used as a sensor in ambient conditions. While this device has direct application as a resonant-based sensor that requires only a single source and measurement system to track multiple resonances, with simple modification, this array could find uses in tunable oscillator and frequency multiplexing contexts.

Keywords: microresonator, array, coupling, electromagnetically-transduced

1. Introduction
Resonant microsystems have found broad applicability in environmental and inertial sensing [1, 2], signal filtering and timing applications [3–6]. Despite this breadth in utility, these devices commonly suffer from throughput constraints, or limitations on the total amount of information that can be processed by the system. These constraints are largely attributable to the frequency response structure of such resonators, and the fact that the current device design paradigm typically exploits only a single-mode response, and thus a single resonance. One way of circumventing the throughput constraint is to elastically-couple multiple microresonators together [7–16]. These arrays are more complicated to design than systems based on isolated microresonators, however, due to the potential for collective behaviors to arise [17–22]. While collective behaviors, such as vibration localization, could find applications in microresonator-based mass sensors, due to their inherent sensitivity to small changes in system parameters, the systems exhibiting such behaviors are also very sensitive to fabrication imperfections. This fact can only partially be mitigated with post-processing [23].

An alternative way to circumvent the aforementioned throughput constraint is to employ arrays of mechanically-
uncoupled, electromagnetically-transduced microresonators [24–26], such as the one shown in figure 1. These devices exploit the interaction between a supplied current in a wire trace on a microresonator surface and an external magnetic field to produce a Lorentz force that is suitable for actuation. Since the device’s vibrations produce a time-varying magnetic flux within the circuit composed of the microresonator’s second wire trace, an induced electromotive force (EMF) is generated and can be used for sensing. The device of interest, shown in figure 1, consists of a microresonators array, wherein, the wire traces used for actuation and sensing follow the outer perimeter of the array. Due to the design of these wire traces, the entire array is actuated and sensed simultaneously. Since these microresonators are physically spaced, such that elastic coupling is negligible, and the lengths of the isolated microresonators are distinct, the electrical response of the array features resonances near the mechanical resonances of the isolated microresonators. Thus, this device has the advantage of being a single-input, single-output (SISO) system, yet also has multiple resonances that can be tailored to suit a specific application and an effective throughput that scales with number of constituent microresonators and/or resonances. Note that this device does not require signal multiplexing [27, 28] or a complicated measurement system [29] to track the multiple resonances. Also, note that though a similar device was developed by Venstra et al [30], the resonances of the device highlighted here are designed to be distinct and can be correlated to the vibration of a specific microresonator in the array. Though few devices have been shown to exhibit frequency responses akin to those subsequently detailed herein, notable examples are arrays of piezoelectric crystals [31] and optomechanically-transduced nanocantilevers [32].

2. Reduced-order modeling

A representative scanning electron micrograph of an electromagnetically-transduced microresonator array is shown in figure 1. This device consists of two, frequency-mistuned microcantilevers (arrays with three microcantilever have been fabricated as well). In the following section, a brief derivation of a linear model for the response of this device is presented. A more detailed derivation that accounts for nonlinear phenomena, but is limited to an isolated microcantilever, can be found in a previous work [26]. It is worth noting that if the intended application of this device is to track the resonances of the array, the excitation can be limited such that nonlinear effects are insignificant.

As previously mentioned, the microcantilevers in the array shown in figure 1 are intentionally designed to have different lengths, or be frequency-mistuned, and are physically spaced so that the resulting elastic coupling is negligible. This results in the collective response of the device having resonances near the mechanical resonances of the isolated microcantilevers. Along the perimeter of these microcantilevers are two integrated Au/Cr wires. When the device is placed in a strong permanent magnetic field, oriented as shown in figure 2 [26], and a current is supplied to the outer wire, colored yellow, a Lorentz force is generated. Since the vibrations of the microcantilever array take place in a strong magnetic field, a time-varying magnetic flux is generated. As predicted by Faraday’s law, this time-varying magnetic flux produces an induced EMF, which can be used for sensing. This induced EMF is then measured as the potential between the two electrical contacts of the inner wire, colored red.

Assuming that the microcantilevers are physically spaced such that mechanical coupling effects can be ignored and the supplied current is small enough that nonlinear effects are trivial, the mechanical dynamics for the displacement $v(x, t)$, where $x$ is the spatial variable referenced to the fixed end of the microcantilever and $t$ is time, of an isolated microcantilever is governed by the Euler–Bernoulli beam equation

$$\rho A \ddot{v} + c \dot{v} + EI \dddot{v} = F(t) \delta(x-l), \quad (1)$$

where $\rho$, $A$, $c$, $E$, $I$ and $l$ are the mass density, cross-sectional area, specific viscous damping coefficient, modulus of elasticity, cross-sectional moment of inertia and undeformed length, respectively, and $(\bullet)$ and $(\bullet)'$ denote derivatives with respect to time $t$ and the spatial variable $x$, respectively. Note that here the excitation is assumed to be a point load, modeled
with a delta function $\delta(x)$, located an infinitesimal distance from the tip of the microcantilever, such that the force does not need to be included in the boundary conditions. This force $F(t)$ is derived from the fundamental definition of the total Lorentz force along the width of the microcantilever

$$F(t) = gB_i(t) \sin \alpha,$$  

(2)

where $g$, $B$, $i(t)$ and $\alpha$ are the width of the microcantilever, the magnitude of the magnetic field strength, the supplied current and the orientation of the magnetic field, as defined in figure 2. Assuming ideal cantilever boundary conditions, the displacement of the microcantilever can be separated into two components related to the spatial and temporal components of the displacement

$$v(x, t) = \Psi(x)z(t).$$  

(3)

Note that since the vibrations of interest are near the first bending mode of the microcantilever, a single-mode expansion is used, where $\Psi(x)$ is defined as

$$\Psi(x) = \cosh \left( \frac{\beta x}{L} \right) - \cos \left( \frac{\beta x}{L} \right) + \lambda \left[ \sinh \left( \frac{\beta x}{L} \right) - \sin \left( \frac{\beta x}{L} \right) \right],$$  

(4)

where $\beta$ is the first solution to the transcendental equation

$$1 + \cos \beta \cosh \beta = 0,$$  

(5)

and $\lambda$ is

$$\lambda = \frac{\sin \beta - \sinh \beta}{\cos \beta + \cosh \beta}.$$  

(6)

By substituting equation (3) into equation (1), multiplying by $\Psi(x)$, integrating over the length of the microcantilever, and scaling the result, an ordinary differential equation can be derived which governs the mechanical dynamics of the microcantilever

$$\ddot{z} + \frac{2\pi f_0}{Q} \dot{z} + 4\pi^2 f_0^2 z = \frac{2Bg \sin \alpha}{\rho A} \dot{i}(t),$$  

(7)

where $f_0$ and $Q$ are the undamped natural frequency and quality factor, respectively, and are defined as

$$f_0 = \frac{\beta^2}{2\pi} \sqrt{\frac{EI}{\rho AI^2}},$$  

(8)

$$Q = \frac{2\pi f_0 \rho A}{c}.$$  

(9)

It is worth noting that $\Psi(x)$ has the properties that

$$\int_0^l \Psi^2(x) \, dx = l,$$  

(10)

$$\int_0^l \Psi(x) \Psi^{\prime\prime}(x) \, dx = \frac{\beta^4}{l^2},$$  

(11)

$$\int_0^l \Psi(x) \delta(x - l) \, dx = 2,$$  

(12)

where the last integral relationship assumes that the delta function is defined such that it is entirely within the domain of $0 < x < l$.

To derive a model for the induced EMF, the magnetic flux of an isolated vibrating microcantilever must first be considered. The magnetic flux $\Phi(t)$ due to the magnetic field $B$ that is in the neighborhood of the surface $S$ of the microcantilever is defined as

$$\Phi(t) = \int_S B \cdot \vec{n} \, dA,$$  

(13)

where $\vec{n}$ is the normal to the surface of the microcantilever. Ignoring nonlinear effects, this normal vector only has a component in the $i$ direction and has a magnitude of $v'$, since the angle of deflection is approximately equal to $v'$ when displacements are small. Using the previous assumption that $v$ can be separated in to spatial and temporal components, the magnetic flux of an isolated microcantilever is approximated as

$$\Phi(t) \approx 2Bg \sin \alpha z.$$  

(14)

Using Faraday’s law [33], which states the induced EMF in a closed circuit is equal to the opposite of the time derivative of the magnetic flux enclosed by this circuit, the induced EMF $V_{\text{EMF}}$ of a single microcantilever is

$$V_{\text{EMF}} = -\frac{d\Phi(t)}{dt} \approx -2Bg \sin \alpha \dot{z}.$$  

(15)

To broaden this result to an array of microcantilevers, the surface $S$ can be extended to the entire array, yielding that the total induced EMF is the superposition of the isolated EMFs. Thus, the final governing equations for the array are

$$\ddot{z}_n + \frac{2\pi f_n}{Q_n} \dot{z}_n + 4\pi^2 f_n^2 z_n = \frac{2Bg \sin \alpha}{\rho A l_n} \dot{i}(t),$$  

(16)

$$V_{\text{EMF}} = \sum_{n=1}^N -2Bg \sin \alpha \dot{z}_n,$$  

(17)

where $N$ is the number of microcantilevers in the array, $l_n$ is the length of the $n$th microcantilever and $f_n$ is the natural frequency of the $n$th microcantilever. Each microcantilever can also have a unique quality factor $Q_n$. While it is possible to set the quality factor for each microcantilever to match experiments, if it is assumed that each microcantilever has the same specific viscous damping coefficient, the quality factors are related by

$$Q_n = Q_0 \frac{l_0^2}{l_n^2},$$  

(18)

where $Q_0$ and $l_0$ are the quality factor and length of the shortest microcantilever, respectively.

As is often the case for microsystems, the measured potential is accompanied by parasitic effects that distort the measurable response from an ideal one. For this system, as was noted in a previous work [26], inductive and resistive coupling between the input and the output of the system are the primary causes for the measured potential, $V_{\text{ME}}$, not being equal to the total induced EMF produced by the microcantilevers’ motion, $V_{\text{EMF}}$. The circuit model shown in figure 3 was developed to aid in quantifying this relationship. The potential used to excite the device via the outer wire trace is denoted as $V_{in}$ and supplies a current $i_{in}$. The Thévenin equivalent resistance of the source is $R_3$ and is nominally 50 $\Omega$. Note that in a previous work $R_3$ was incorrectly reported as 10 k$\Omega$ [26]. The circuits composed of the probe station and the inner and outer wire traces are both
used for this particular device when the induced EMF is due to the wire loops are modeled as resistors \( R_{M} \). The inner and outer wire loops are assumed to have identical resistances and the induced EMF is much larger than \( R_{Si} \). As current-controlled voltage sources, note that the polarities of these sources are opposite due to the polarity of the inner and outer wire loops being opposite. To account for the conduction between the inner and outer wires, a lumped resistor \( R_{Si} \) is used. Effects related to inductive coupling are included with two inductors \( L \) and mutual inductance \( M \). The resistor \( R_{M} \) is the input impedance of the lock-in amplifier used to acquire the measured voltage \( V_{M} \). Note that \( R_{M} \) is assumed to be much larger than \( R_{Au/Cr} \), such that \( i_{in} \approx i(t) \) and \( R_{M} \) is assumed to be much larger than \( R_{Co} \), such that \( i_{out} \approx 0 \). This diagram was presented in an earlier work \([26]\) on an isolated microresonator, but can still be used for this particular device when the induced EMF is due to the entire ensemble of microresonators.

\begin{align}
V_{1} - V_{2} &= V_{2} - V_{EMF}, \quad (21) \\
\frac{V_{1} - V_{2}}{R_{Si}} &= \frac{V_{2} - V_{EMF}}{R_{Au/Cr}},
\end{align}

and the fundamental relationship for the induced EMF due to mutual inductance effects,

\begin{equation}
V_{2} - V_{M} = M \frac{d(i(t))}{dt}, \quad (22)
\end{equation}

an equation for the measured potential can be derived:

\begin{equation}
V_{M} = c_{1}V_{EMF} + c_{2}V_{in} - c_{3}V_{in}, \quad (23)
\end{equation}

where

\begin{align}
c_{1} &= \frac{R_{Si}}{R_{Si} + R_{Au/Cr}}, \quad (24) \\
c_{2} &= \frac{R_{Au/Cr}^{2}}{R(R_{Au/Cr} + R_{Si})}, \quad (25) \\
c_{3} &= \frac{M}{R}. \quad (26)
\end{align}

It is important to point out that \( M \) in equation (22) is a positive number and captures the fact that the direction of current in the inner and outer wires are in opposite directions. As noted earlier, the primary contributor to the mutual inductance is the probe station used for actuation and sensing, thus if the device was wire bonded, this inductance could be significantly reduced. While not obvious from equation (23), near a mechanical resonance there is destructive interference between the induced EMF and the potential due to resistive coupling effects. To combat this effect, the polarity of the measured potential can be reversed, which mathematically amounts to changing the signs of \( c_{1} \) and \( c_{2} \). Note that the sign of \( c_{3} \) does not change with the reverse polarity configuration. Due to the particularly small responses at atmospheric pressure, the reverse polarity configuration is used in all experimentally-recovered responses as it reduces the effects of antiresonances due to resistive coupling and helps improve the signal return. For clarity, the authors of this work are cognizant that polarity-dependent responses are abnormal, but polarity-dependent responses in integrated circuit transformers, which are very similar to the presented device, have been observed before \([34, 35]\).

Using estimates of the dimensions and material properties for the microcantilever array, which are given in table 1, amplitude and phase responses of the measurable potential can be generated. Two different quality factors are used to model the device’s response at different pressures. The low-pressure quality factor of 4800 and the atmospheric-pressure quality factor of 200 were selected to match experiments conducted at 75 \( \mu \)Torr and 746 Torr, respectively. To demonstrate the differences between the standard and reverse polarity configurations, the low-pressure responses using the standard polarity configuration are shown in figure 4, while the low-pressure responses using the reverse polarity configuration are shown in figures 5 and 6. The atmospheric-pressure responses using the reverse polarity configuration are shown in figure 7. In all of the theoretical responses shown, an excitation voltage of 10 mV was used. To show the differences between the mechanical and electrical responses of the device, the mechanical frequency response functions of the
Table 1. Dimensions and material properties used to study the dynamic response of a representative electromagnetically-transduced microcantilever array. Based on these values, the natural frequencies of the array are expected to be approximately 66.72 kHz and 73.93 kHz at low pressure. The quality factors were chosen to match the experimental values obtained from frequency sweeps conducted within the two different pressure regimes.

<table>
<thead>
<tr>
<th>Physical parameter</th>
<th>Value</th>
</tr>
</thead>
<tbody>
<tr>
<td>Length of beam 1 (l₁)</td>
<td>200 μm</td>
</tr>
<tr>
<td>Length of beam 2 (l₂)</td>
<td>190 μm</td>
</tr>
<tr>
<td>Width (g)</td>
<td>50 μm</td>
</tr>
<tr>
<td>Thickness (t₀)</td>
<td>2 μm</td>
</tr>
<tr>
<td>Modulus of elasticity (E)</td>
<td>159 GPa</td>
</tr>
<tr>
<td>Mass density (ρ)</td>
<td>2330 kg m⁻³</td>
</tr>
<tr>
<td>Quality factor at 75 μTorr (Q₀)</td>
<td>4800</td>
</tr>
<tr>
<td>Magnetic field strength (B)</td>
<td>0.1 T</td>
</tr>
<tr>
<td>Magnetic field orientation (α)</td>
<td>π/2 rad</td>
</tr>
<tr>
<td>Au/Cr trace resistance (RωAu/Cr)</td>
<td>100 Ω</td>
</tr>
<tr>
<td>Lumped substrate resistance (R₀)</td>
<td>600 kΩ</td>
</tr>
<tr>
<td>Mutual inductance (M)</td>
<td>0.2 μH</td>
</tr>
</tbody>
</table>

microcantilevers are shown in red (short dashes) and blue (long dashes) and use the left vertical axis, while the electrical response is shown in black (solid curve) and uses the right vertical axis. For clarity, the mechanical frequency response is defined as the velocity of an isolated microcantilever, measured at its tip, normalized with respect to the excitation voltage.

As was discussed in [26], inductive and resistive coupling between the input and output of the device alters the response. This input/output coupling issue has been observed in other micro/nanosystems, including other electromagnetically-transduced microresonators [24], electrostatically-transduced resonators [36–39] and carbon nanotubes [40, 41], and is sometimes referred to as feedthrough or parasitic feedthrough. A common feature of systems with input/output coupling are antiresonances. Antiresonances can be observed in the response of this device, even when the device’s output is only weakly inductively and resistively coupled to the input. This is due to destructive interference between the induced EMF and the parasitic signals. Antiresonances due to inductive coupling are independent of the polarity of the measured response, but antiresonances due to resistive coupling can be partially quenched by reversing the polarity of the measured response. Thus, as mentioned earlier, the reverse polarity configuration is used in all experimentally-recovered responses to mitigate the antiresonance effects.

Another effect related to input/output coupling is that the input voltage biases the response such that in frequency ranges where the mechanical response is trivial, the electrical response linearly scales with the input voltage. In addition to creating a qualitative difference between the mechanical and electrical response of the device, this also exacerbates issues related to noise. For the mechanical response, non-resonant noise contributions are significantly filtered. For the electrical response, however, input/output coupling allows some of the non-resonant noise contributions to be passed through to the output. This makes the recovered electrical response more susceptible to noise from the excitation and measurement systems [39].

Inductive and resistive coupling also alter the phase response of the device such that the non-resonant phase is dictated by the particular form of input/output coupling. The phase response is also altered at resonance, which can lead to implementation issues if the device is intended to be used in a closed-loop system. Also note that in figure 4, which uses the reverse polarity configuration, the non-resonant phase is close to −90° and that near a resonance, the phase tends to approach ±180°, but in figure 5, which uses the reverse polarity configuration, the non-resonant phase is close to 90° and that near a resonance, the phase tends to approach 0°. In an experimental situation, these differences can be used to identify the polarity of the sensing circuit, if there is some ambiguity.

Lastly, it is important to note that input/output coupling causes the mechanical and electrical resonant frequencies to
Figure 5. Theoretical amplitude and phase responses at 75 \( \mu \text{Torr} \) for an excitation of 10 mV obtained using the reverse polarity configuration. The only difference between this case and the one shown in figure 4 is the polarity of the measurement, yet there are subtle differences in the responses. Antiresonance effects due to resistive coupling are smaller, thus the amplitude response close to a mechanical resonance is marginally greater than in figure 4. In addition, the non-resonant phase is approximately 180° out of phase with the non-resonant phase shown in figure 4 and the phase near a mechanical resonance tends to approach 0° instead of ±180°.

be distinct, which might lead one to erroneously identify differences between the observed resonant frequencies and the designed resonant frequencies as being caused by fabrication imperfections. This effect is shown clearly in figure 6. In regards to the operation of the device at different pressures, changes in the response near a mechanical resonance are more dramatic at low pressure than at atmospheric pressure. Thus, when operating the device at atmospheric pressure, relatively small frequency increments near a mechanical resonance might be needed, as compared to a device that does not have input/output coupling issues, to resolve a response due to array vibrations.

3. Experimental results

To demonstrate the feasibility of a SISO device based on electromagnetic-transduction, devices were fabricated using silicon-on-insulator technology with a four step process, as shown in figure 8, at the Birck Nanotechnology Center. In the first process, Au/Cr was deposited on the surface of the 10.16 cm, p-type, high resistivity (1000 \( \Omega \text{cm} \)) wafer and selectively removed using photolithographic processes to form the wire traces and contact pads. Next, using reactive ion etching, the device layer of the wafer was etched to form the microcantilevers. To form the trenches that the microcantilevers vibrate in, deep reactive ion etching was used to etch the handle wafer from the bottom side. Finally, the microcantilevers were released from the silicon dioxide insulator layer using hydrofluoric acid. The device that was used to collect the results shown in this work, with the probes used for actuation and sensing on the device’s contact pads, is depicted in figure 9. Due to issues with the wire traces being removed during the release process, not all of the silicon dioxide, false colored in figure 9 as purple, was removed. Note that the inner and outer wire traces are false colored as red and yellow, respectively, to be consistent with the convention used in figure 1. It is believed that the reason as to why the natural frequencies of the tested device do not more closely match the predicted ones is in part due to this residual silicon dioxide, as this residual decreases the effective length
of the microcantilevers, which in turn increases their natural frequencies. One benefit of this residual silicon dioxide is that effects related to elastic coupling are further reduced as compared to a fully-released array.

It is important to note that as in any microstructure, these microcantilevers are susceptible to common fabrication issues, including poor photolithographic mask alignment, device layer variability, and over/underetching during structural release. In a previous work by the authors [26], a slightly thicker than reported (by the wafer supplier) device layer was identified as the reason why the experimentally-estimated natural frequencies were greater than the ones obtained from the model. Here, as noted above, there were issues related to device release. Despite these issues, since the microcantilevers in the array are physically spaced such that they are mechanically uncoupled, for the most part device imperfections have only a local effect. Thus, if a device is overetched such that ideal boundary conditions are not applicable, for example, the issue is isolated to that particular element in the array.

For the experiments described in this work, a grade N38SH sintered NdFeB slab magnet manufactured by Eclipse Magnetics (model N317) and of dimensions 2.5 cm × 2.5 cm × 0.25 cm was used to generate the magnetic field. The remanence of these magnets range from 1.22–1.26 T; however, the magnetic field strength near the poles of the magnet is usually only 20%–50% of the remanence [42]. In order to maximize the component of the magnetic field used for transduction, the array was placed near the edge of the magnet, and the microcantilevers in the array were aligned such that the fixed end of the beams were parallel to the magnet’s edge. While this magnet and experimental setup facilitated experiments in a laboratory setting, portable applications would require either integrating magnetic material [42–47] or a solenoid [48–51]. Both methods have distinct advantages and pitfalls, but these relatively recent citations demonstrate that progress is being made and that it may be
feasible to build complete miniature systems that use one of the arrays detailed in this work.

A block diagram of the experimental setup is shown in figure 10. Frequency sweeps are controlled by a LabView interface and the setup is capable of acquiring both mechanical and electrical responses. An Agilent 33220A arbitrary waveform generator was used as the source, however, due to issues with short-term frequency stability, an Agilent 8648D synthesized signal generator was used as an external reference. It is important to note that the Agilent 33220A was operated with a fixed output impedance of 50 Ω. Transduction and pressure control was enabled by a Suss Microtec PLV-50 probe station. The velocity of the microcantilevers in the array was measured using a Polytec MSA-400 laser Doppler vibrometer and both amplitude and phase data from mechanical and electrical responses were recovered using a Stanford Research Systems SR830 lock-in amplifier. Due to differences in the response structure between mechanical and electrical measurements, a 3 ms time constant and 400 ms delay time were used for mechanical measurements and a 300 ms and 3 s delay time were used for electrical measurements. It is worth noting that in the mechanical responses, noise contributions at frequencies not close to a mechanical resonance are significantly filtered, but due to input/output coupling in the electrical responses, noise is only marginally filtered.

Figures 11–13 depict the experimentally-recovered responses of the device operated at both low pressure and atmospheric pressure. The results from low-pressure testing determined that the low-pressure resonant frequency of the microcantilever on the left in figure 9 was 77.449 kHz, while for the microcantilever on the right it was 78.133 kHz. The associated quality factors were 4397 and 4797, respectively. In figure 11, and in the rest of the experimentally-recovered responses, mechanical frequency responses are shown in red (circles) and blue (crosses) for the left and right microcantilever, respectively, and electrical responses are shown in black (dots). Note that an excitation of 20 mVpp was used. As was discussed in the previous section, several effects related to inductive and resistive coupling are shown: antiresonances and response bias in the amplitude responses and the non-resonant phase response being dominated by parasitic effects. It is also worth noting that the mechanical responses show that any coupling between the microcantilevers, elastic or electrical, is negligible.

Figure 12 shows the results of a different electrical response, which was collected under the same conditions, but over a smaller frequency range. This figure shows that the mechanical and electrical resonant frequencies are distinct due to inductive and resistive coupling effects.

Results from trials conducted at atmospheric pressure are shown in figure 13. The resonant frequencies of the left and right microcantilevers were 77.106 kHz and 77.776 kHz, respectively, with associated quality factors of 202 and 190, respectively. Note that since the excitation used in these trials was 100 mVpp, the magnitude of the measured signal was larger; however, due to the quality factors being smaller, the component of the response due to the vibration of the array is much smaller. This decrease in the component of the response due to array vibrations, besides qualitatively changing the response structure, necessitates in application an excitation...
Figure 11. Experimentally-recovered amplitude and phase responses of the device obtained at 75 μTorr using the reverse polarity configuration when the excitation voltage was 20 mVpp. The data shown in red (circles) and blue (crosses) are the mechanical responses of the left and right microcantilevers, respectively, while the response in black (dots) is the electrical response. Note the in the electrical amplitude response, antiresonances and response bias exist, while in the electrical phase response, non-resonant responses are dominated by inductive and resistive coupling effects.

Figure 12. Experimentally-recovered amplitude and phase responses collected under the same conditions as in figure 11, except using smaller frequency increments. Note that the same effects related to inductive and resistive coupling depicted in figure 11 are present here, with the addition that the mechanical and electrical resonant frequencies are distinct due to these coupling issues.

and measurement system that is capable of resolving small changes in amplitude and phase over a small frequency range. In addition to the parasitic coupling effects that were observed at low-pressure testing, relatively larger excitations are needed to produce repeatable responses. This last effect is related to the noise characteristics of the particular excitation and measurement systems used. Thus, it is recommended that in future designs, the actuation wire trace should be designed for improved power handling, the sensing wire trace should be coiled to increase the signal return due to array vibrations, the relative geometry of the wire traces and contact pads should be optimized for minimal resistive coupling, and if possible the device should be wire bonded to reduce inductive coupling effects. Methods related to feedthrough cancellation might also be employed to mitigate issues related to inductive and resistive coupling [37–39]. Provided these alterations to the array’s design yield the previously-stated improvements, a lock-in amplifier might not be needed, which would enabling the measurement of microcantilevers with higher natural frequencies and an overall more compact system.

The average power consumption metrics associated with the low-pressure and atmospheric-pressure results presented in this section were approximately 0.2 μW and 5 μW, respectively. Because of this, effects related to Joule heating are believed to be largely insignificant. However, this might not be true with a fully-integrated device, as it is expected that the majority of power consumed by the fully-integrated device will stem from attendant electronics. Accordingly, these electronics would need to be designed to consume minimal power and produce minimal heat to ensure that they do not significantly degrade the performance of the array.

3.1. Parametric identification

In order to validate the various assumptions needed to design the SISO electromagnetically-transduced micoresonator array presented in this work, and to demonstrate how one might track multiple resonances with the electrical response of this array, this subsection describes a method capable of estimating...
be the ones that minimize an error function that is the squared
employed \[52\], where the estimated parameters are defined to
field.
of the microcantilevers or the strength of the local magnetic
more difficult to measure directly, including the thickness
adopted approach also estimates values that are considerably
such as the natural frequencies of the microcantilevers,
model parameters. In addition to identifying parameters,
such as the natural frequencies of the microcantilevers,
which are easily measured provided proper equipment, the
adopted approach also estimates values that are considerably
more difficult to measure directly, including the thickness
of the microcantilevers or the strength of the local magnetic
field.

In this work, a nonlinear least-squares method was employed \[52\], where the estimated parameters are defined to be the ones that minimize an error function that is the squared difference between the model and the measured response. In particular, the error function used was

\[
E(\hat{p}) = \sum_{n=1}^{M} (a_n - a_n^*)^2 + (\phi_n - \phi_n^*)^2, \tag{27}
\]

where \(\hat{p}\) is a vector containing the parameters of the model, \(M\) is the number of measurements, \(a_n\) and \(\phi_n\) denote the amplitude and phase predicted by the model, and the superscript \(^*\) is used to denote a measured value. Note that this model is only capable of uniquely estimating certain parameters, thus the values for mass density, modulus of elasticity, Au/Cr trace resistance, and microcantilever width provided in table 1 are assumed to be known values. The to-be-determined parameters are the lengths of the microcantilevers, the thickness of the microcantilevers, the respective quality factors for these microresonators, the component of the local magnetic field in the \(i\) direction (see figure 2 for the orientation of the magnetic field), the lumped substrate resistance, and the mutual inductance. Note that the direction of the magnetic field, or the sign of the component of the local magnetic field used for sensing, cannot be determined using this method, due to its quadratic influence on the measured response.

One of the challenges with nonlinear least-squares methods is providing initial estimates for the parameters. To do this, a global minimization method called particle swarm optimization (PSO), previously implemented in \[53\], was used. Using a swarm of 5000 particles, a search space constrained by the limits provided in table 2 was used. Note that, in general, the bounds for the parameters are within 45% of a set of parameters that yielded a close fit to the data. The constraints for the lengths, however, are based on approximate measurements of the micrograph in figure 9. The bounds for the device layer thickness given by the manufacturer of the SOI wafer was \(\pm 0.5\ \mu m\). Based on measurements with a profilometer conducted during fabrication, and how the bounds for microcantilever thickness are coupled to the bounds for the lengths of the microcantilevers via the natural frequencies of these structures, bounds of \(\pm 0.15\ \mu m\) seemed more reasonable. In addition, a nonlinear constraint that the estimated parameters must yield natural frequencies within 100 Hz of the estimated values given in the previous section was used to mitigate the effects of poor estimates for the lengths and thickness of the microcantilevers. Satisfactory convergence for this method was determined when no change in the error function occurred after 50 iterations.

After estimates for parameters were found using PSO for the trials conducted at 75 \(\mu\)Torr and atmospheric pressure, these values were used as initial estimates to a nonlinear least-squares estimation algorithm implemented by

![Figure 13. Experimentally-recovered amplitude response of the device obtained at 746 Torr using the reverse polarity configuration when the excitation voltage was 100 mVpp. Due to a decrease in the quality factors at atmospheric pressure as compared to low-pressure testing, the relative magnitude of the measured EMF due to the vibration of the array is decreased. Even though the electrical response due to mechanical vibrations is small near a mechanical resonance, the excitation and measurement system was capable of resolving the changes in the response due to array vibrations. Thus, even in the presence of inductive and resistive coupling, this device can still be used to detect shifts in the mechanical resonances of the microcantilevers at atmospheric pressure.](image-url)
It is important to highlight that while the adopted parametric identification technique is capable of estimating the variability of the parameters that were assumed to be unknown, it is not capable of estimating the variability of the parameters that were assumed to be known. This results from limitations of both the employed least-squares estimation technique and the experimental setup. While optical methods were used to confirm that the actual and nominal values for the widths of the microcantilevers were similar in magnitude, and similarly a multimeter was used to estimate the Au/Cr trace resistance, no tests were conducted to directly estimate the mass density or modulus of elasticity. Thus, the accuracy and validity of the estimated parameters are contingent on the accuracy and stationarity of the parameters that were assumed to be known.

Figures 14 and 15 depict overlays of the measured and modeled responses using the parameters obtained herein. Overall, both predictions describe the data fairly well. More importantly, the parameter estimates given in tables 3 and 4 provide validation for the model derived in this work. As referenced at the beginning of this subsection, estimates for parameters that are difficult to directly measure, like the thickness of the microcantilevers and the strength of the local magnetic field, are provided and are reasonable based on the nominal values provided by the manufacturers. In addition, while under ideal circumstances, one might be able to directly measure the lengths of the microcantilevers using optical methods, this was not possible with the array used in this work due to residual silicon dioxide changing the effective lengths of these structures. Using the parameter estimation method described in this subsection, estimates for these lengths were found, and they appear to be reasonable based on inspection of the micrograph included in figure 9.

<table>
<thead>
<tr>
<th>Parameter estimates from 75 μTorr trials</th>
<th>Value</th>
</tr>
</thead>
<tbody>
<tr>
<td>Length of beam 1 (l1)</td>
<td>190.40 ± 0.05 μm</td>
</tr>
<tr>
<td>Length of beam 2 (l2)</td>
<td>189.56 ± 0.05 μm</td>
</tr>
<tr>
<td>Natural frequency 1 (f1)</td>
<td>77.4508 ± 0.0002 kHz</td>
</tr>
<tr>
<td>Natural frequency 2 (f2)</td>
<td>78.1337 ± 0.0002 kHz</td>
</tr>
<tr>
<td>Thickness (t0)</td>
<td>2.104 ± 0.001 μm</td>
</tr>
<tr>
<td>Quality factor 1 (Q1)</td>
<td>4323.2 ± 0.2</td>
</tr>
<tr>
<td>Quality factor 2 (Q2)</td>
<td>4470.1 ± 0.2</td>
</tr>
<tr>
<td>Magnetic field strength (B sin α)</td>
<td>0.139 ± 0.001 T</td>
</tr>
<tr>
<td>Lumped substrate resistance (R0)</td>
<td>456 ± 2 Ω</td>
</tr>
<tr>
<td>Mutual inductance (M)</td>
<td>0.3214 ± 0.0009 μH</td>
</tr>
</tbody>
</table>

<table>
<thead>
<tr>
<th>Parameter estimates from atmospheric pressure trials</th>
<th>Value</th>
</tr>
</thead>
<tbody>
<tr>
<td>Length of beam 1 (l1)</td>
<td>200 ± 800 μm</td>
</tr>
<tr>
<td>Length of beam 2 (l2)</td>
<td>200 ± 800 μm</td>
</tr>
<tr>
<td>Natural frequency 1 (f1)</td>
<td>77.068 ± 0.007 kHz</td>
</tr>
<tr>
<td>Natural frequency 2 (f2)</td>
<td>77.765 ± 0.009 kHz</td>
</tr>
<tr>
<td>Thickness (t0)</td>
<td>2 ± 10 μm</td>
</tr>
<tr>
<td>Quality factor 1 (Q1)</td>
<td>180 ± 10</td>
</tr>
<tr>
<td>Quality factor 2 (Q2)</td>
<td>170 ± 9</td>
</tr>
<tr>
<td>Magnetic field strength (B sin α)</td>
<td>0.1 ± 0.9 T</td>
</tr>
<tr>
<td>Lumped substrate resistance (R0)</td>
<td>486 ± 1 kΩ</td>
</tr>
<tr>
<td>Mutual inductance (M)</td>
<td>0.282 ± 0.0008 μH</td>
</tr>
</tbody>
</table>
One important issue with the method presented here is that the parameter estimates that influence the mechanical dynamics of the array are sensitive to how strongly damped the microcantilevers are. That is, the error bounds for the parameters that influence the mechanical response that correspond to the high vacuum trial, and in turn a low-damping environment, are smaller than the same parameters corresponding to the atmospheric pressure trial, or a high-damping environment. Despite these issues, and the previously-discussed effects with inductive and resistive coupling altering the measured response, even at atmospheric pressure it is still possible to detect small changes in the natural frequencies of the microcantilevers, as the percent error of the measured values is approximately 0.01%.

4. Conclusions and future directions

In this work, a SISO electromagnetically-transduced microresonator array with multiple, easily-tailored resonances was presented. The device was tested in low- and atmospheric-pressure environments, demonstrating the feasibility of operating this device in ambient conditions. A direct application of this research is resonant-based sensors that require only a single source and measurement system to track multiple resonances, but with a few simple modifications, these arrays could be used in tunable oscillators and in frequency multiplexing operations. The utilized distinct form of electromagnetic transduction suffers from intrinsic parasitic coupling between the input and output due to inductive and resistive effects, though methods related to feedthrough cancellation could be used to mitigate this issue. It is believed that much of the mutual inductance is due to the probe station, thus wire bonding the device should reduce much of these effects. In addition, redesigning the wire traces should also enable a reduction in the resistive coupling effects, improve power handling and increase signal return. Future work will focus on improving the design of this device and implementing larger arrays, making further progress towards a device with improved throughput.

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